



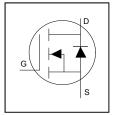
## **Application**

- Brushed Motor drive applications
- BLDC Motor drive applications
- Battery powered circuits
- Half-bridge and full-bridge topologies
- Synchronous rectifier applications
- Resonant mode power supplies
- OR-ing and redundant power switches
- DC/DC and AC/DC converters
- DC/AC Inverters

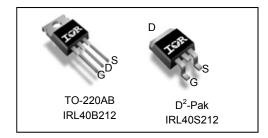
#### **Benefits**

- Optimized for Logic Level Drive
- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- Lead-Free
- RoHS Compliant, Halogen-Free

HEXFET® Power MOSFET



V <sub>DSS</sub>	40V
R <sub>DS(on)</sub> typ.	1.5m $\Omega$
max	1.9m $\Omega$
I <sub>D</sub> (Silicon Limited)	<b>254A</b> ①
D (Package Limited)	195A



G	D	S
Gate	Drain	Source

Book nort number	Dookogo Type	Standard Pack		Orderable Part Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
IRL40B212	TO-220	Tube	50	IRL40B212
IRL40S212	D <sup>2</sup> -Pak	Tape and Reel	800	IRL40S212

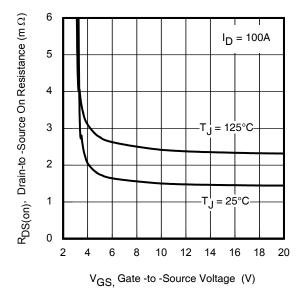


Fig 1. Typical On– Resistance vs. Gate Voltage

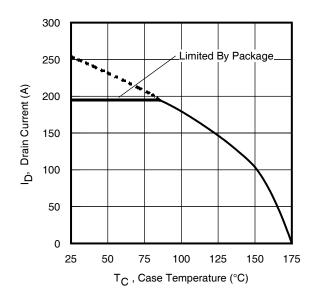


Fig 2. Maximum Drain Current vs. Case Temperature



## **Absolute Maximum Rating**

Symbol	Parameter	Max.	Units
$I_D$ @ $T_C$ = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	254①	
$I_D$ @ $T_C$ = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	<b>179</b> ①	^
$I_D$ @ $T_C$ = 25°C			A
I <sub>DM</sub>	Pulsed Drain Current ②	990 *	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	231	W
	Linear Derating Factor	1.5	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
T <sub>J</sub>	Operating Junction and Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting Torque, 6-32 or M3 Screw	10 lbf·in (1.1 N·m)	

### **Avalanche Characteristics**

E <sub>AS (Thermally limited)</sub>	Single Pulse Avalanche Energy ③	342	1
E <sub>AS (Thermally limited)</sub>	Single Pulse Avalanche Energy ®	790	mJ
I <sub>AR</sub>	Avalanche Current ②	Soo Fig 15, 16, 220, 22h	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ②	See Fig 15, 16, 23a, 23b	mJ

#### Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ hetaJC}$	Junction-to-Case ®		0.65	
$R_{\theta CS}$	Case-to-Sink, Flat Greased Surface	0.50		°C /\ \
$R_{ heta JA}$	Junction-to-Ambient		62	°C/W
$R_{ hetaJA}$	Junction-to-Ambient (PCB Mount) ®		40	

Static @  $T_1 = 25^{\circ}$ C (unless otherwise specified)

otatio @ ij	20 0 (diffess other wise specifica)					
Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	40			<b>V</b>	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.03		V/°C	Reference to 25°C, I <sub>D</sub> = 2mA ②
D	Static Drain to Source On Registance		1.5	1.9	m()	V <sub>GS</sub> = 10V, I <sub>D</sub> = 100AS
$R_{DS(on)}$	Static Drain-to-Source On-Resistance		1.9	2.4	mΩ	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 50A ⑤
$V_{GS(th)}$	Gate Threshold Voltage	1.0		2.4	V	$V_{DS} = V_{GS}, I_{D} = 150 \mu A$
ı	Drain-to-Source Leakage Current			1.0	μA	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$
I <sub>DSS</sub>	Dialii-to-Source Leakage Current			150	μΑ	$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 20V$
I <sub>GSS</sub>	Gate-to-Source Reverse Leakage			-100	IIA	$V_{GS} = -20V$
$R_G$	Gate Resistance		1.6		Ω	

## Notes:

- Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 195A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements. (Refer to AN-1140)
- Repetitive rating; pulse width limited by max. junction temperature.
- Limited by  $T_{Jmax}$ , starting  $T_J$  = 25°C, L = 0.07mH,  $R_G$  = 50 $\Omega$ ,  $I_{AS}$  = 100A,  $V_{GS}$  =10V.
- $I_{SD} \leq 100 A$ ,  $di/dt \leq 950 A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 175 ^{\circ} C$ .
- Pulse width  $\leq 400 \mu s$ ; duty cycle  $\leq 2\%$ .
- $C_{oss}$  eff. (TR) is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- $C_{oss}$  eff. (ER) is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$
- $R_{\theta}$  is measured at  $T_J$  approximately 90°C.
- When mounted on 1 inch square PCB (FR-4). Please refer to AN-994 for more details: http://www.irf.com/technical-info/appnotes/an-994.pdf
- Limited by  $T_{Jmax}$ , starting  $T_J$  = 25°C, L = 1mH,  $R_G$  = 50 $\Omega$ ,  $I_{AS}$  = 40A,  $V_{GS}$  =10V.
- Pulse drain current is limited at 780A by source bonding technology.

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# Dynamic Electrical Characteristics @ $T_J$ = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	256			S	$V_{DS} = 10V, I_{D} = 100A$
$Q_g$	Total Gate Charge		91	137		I <sub>D</sub> = 100A
$Q_gs$	Gate-to-Source Charge		25		nC	V <sub>DS</sub> = 20V
$Q_gd$	Gate-to-Drain Charge		46			V <sub>GS</sub> = 4.5V⑤
Q <sub>sync</sub>	Total Gate Charge Sync. (Qg- Qgd)		45			
$t_{d(on)}$	Turn-On Delay Time		39			$V_{DD} = 20V$
t <sub>r</sub>	Rise Time		154			I <sub>D</sub> = 30A
$t_{d(off)}$	Turn-Off Delay Time		88		ns	$R_G = 2.7\Omega$
t <sub>f</sub>	Fall Time		84			V <sub>GS</sub> = 4.5V⑤
C <sub>iss</sub>	Input Capacitance		8320			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		1050			V <sub>DS</sub> = 25V
C <sub>rss</sub>	Reverse Transfer Capacitance		790		pF	f = 1.0MHz, See Fig.7
Coss eff.(ER)	Effective Output Capacitance (Energy Related)		1250			V <sub>GS</sub> = 0V, VDS = 0V to 32V⑦
Coss eff.(TR)	Output Capacitance (Time Related)		1580			V <sub>GS</sub> = 0V, VDS = 0V to 32V <sup>©</sup>

## **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current (Body Diode)			254①		MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ②			990*	A	integral reverse p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.2	V	$T_J = 25^{\circ}C, I_S = 100A, V_{GS} = 0V$ §
dv/dt	Peak Diode Recovery dv/dt⊕		6.0		V/ns	$T_J = 175^{\circ}C, I_S = 100A, V_{DS} = 40V$
t	Reverse Recovery Time		30		ns	$T_{J} = 25^{\circ}C$ $V_{DD} = 34V$
t <sub>rr</sub>	reverse recovery fillie		32		113	$T_J = 125^{\circ}C$ $I_F = 100A$ ,
	Povorce Pocovery Charge		26		nC	$T_J = 25^{\circ}C$ di/dt = 100A/µs ©
Q <sub>rr</sub>	Reverse Recovery Charge		28		IIC	<u>T<sub>J</sub> = 125°C</u>
I <sub>RRM</sub>	Reverse Recovery Current		1.4		Α	T <sub>J</sub> = 25°C

Submit Datasheet Feedback



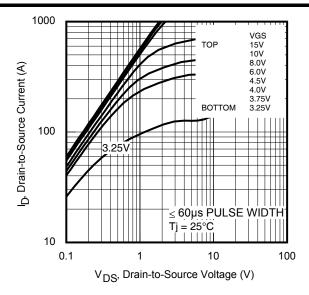


Fig 3. Typical Output Characteristics

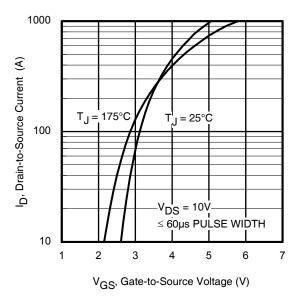


Fig 5. Typical Transfer Characteristics

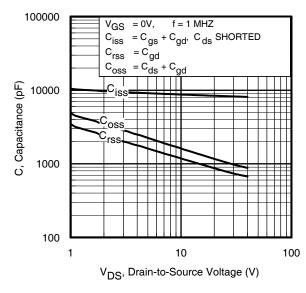


Fig 7. Typical Capacitance vs. Drain-to-Source Voltage

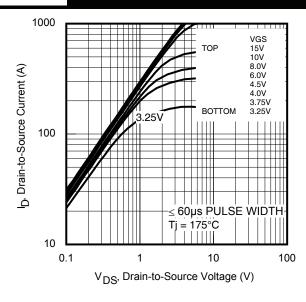


Fig 4. Typical Output Characteristics

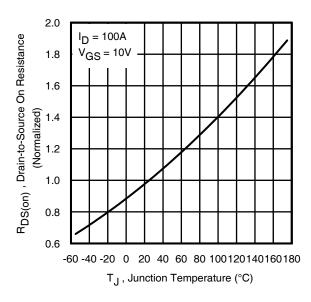


Fig 6. Normalized On-Resistance vs. Temperature

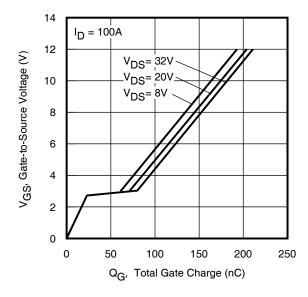


Fig 8. Typical Gate Charge vs.Gate-to-Source Voltage



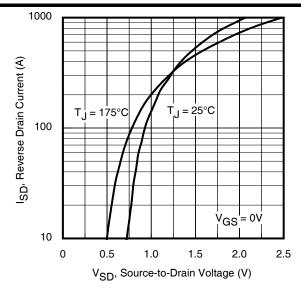


Fig 9. Typical Source-Drain Diode Forward Voltage

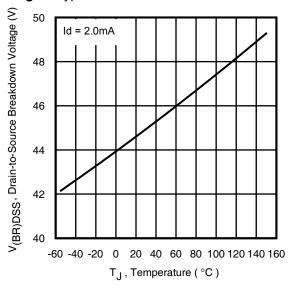


Fig 11. Drain-to-Source Breakdown Voltage

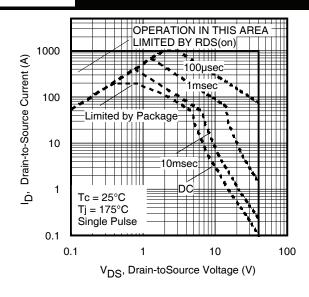


Fig 10. Maximum Safe Operating Area

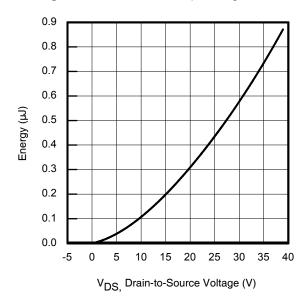


Fig 12. Typical Coss Stored Energy

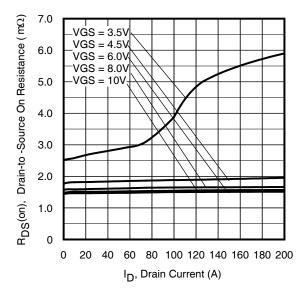


Fig 13. Typical On- Resistance vs. Drain Current



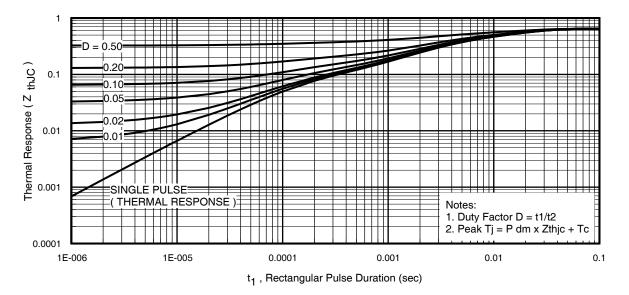


Fig 14. Maximum Effective Transient Thermal Impedance, Junction-to-Case

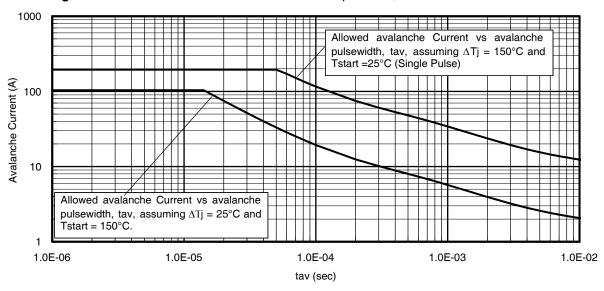


Fig 15. Avalanche Current vs. Pulse Width

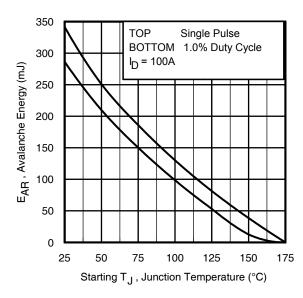


Fig 16. Maximum Avalanche Energy vs. Temperature

### Notes on Repetitive Avalanche Curves , Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

1. Avalanche failures assumption:

Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>imax</sub>. This is validated for every

- 2. Safe operation in Avalanche is allowed as long  $asT_{j\text{max}}$  is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 23a, 23b.
- 4. P<sub>D (ave)</sub> = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. l<sub>av</sub> = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{imax}$ (assumed as 25°C in Figure 14, 15).

 $t_{av}$  = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see Figure 14) PD (ave) = 1/2 (  $1.3 \cdot BV \cdot I_{av}$ ) =  $\Delta T / Z_{thJC}$ 

 $I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$ 

 $E_{AS (AR)} = P_{D (ave)} \cdot t_{av}$ 



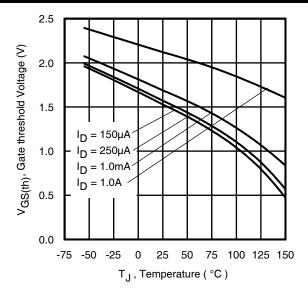


Fig 17. Threshold Voltage vs. Temperature

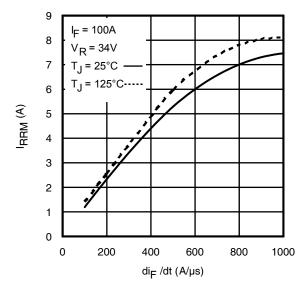


Fig 19. Typical Recovery Current vs. dif/dt

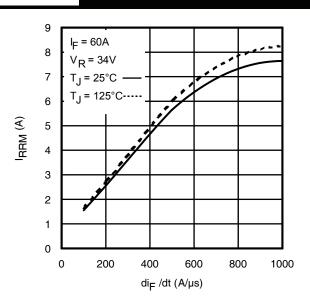


Fig 18. Typical Recovery Current vs. dif/dt

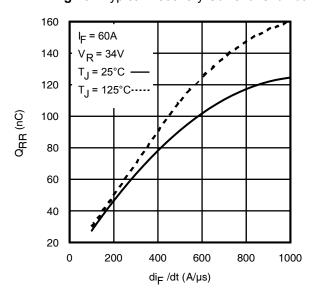


Fig 20. Typical Stored Charge vs. dif/dt

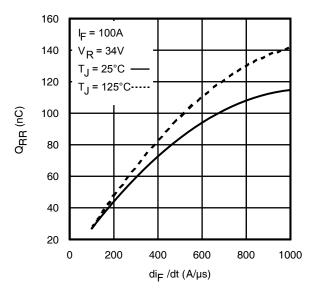


Fig 21. Typical Stored Charge vs. dif/dt



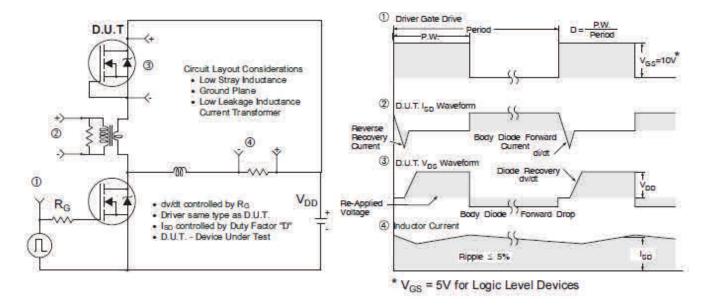


Fig 22. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

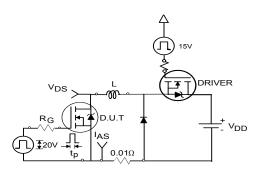


Fig 23a. Unclamped Inductive Test Circuit

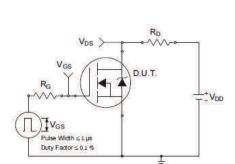


Fig 24a. Switching Time Test Circuit

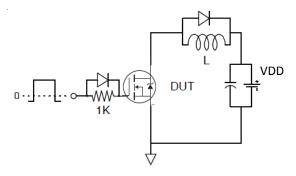


Fig 25a. Gate Charge Test Circuit

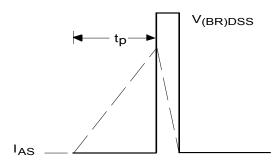


Fig 23b. Unclamped Inductive Waveforms

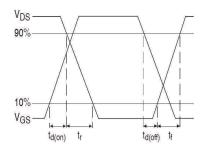


Fig 24b. Switching Time Waveforms

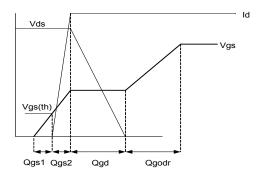
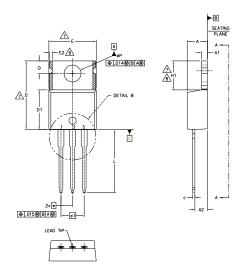
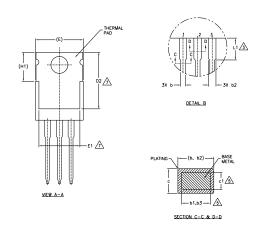


Fig 25b. Gate Charge Waveform



## TO-220AB Package Outline (Dimensions are shown in millimeters (inches))





- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994.
- DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].
- LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.
- DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

DIMENSION 61, 63 & c1 APPLY TO BASE METAL ONLY.

- CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1
- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING 8.-AND SINGULATION IRREGULARITIES ARE ALLOWED.
- OUTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (max.) AND D2 (min.) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE.

SYMBOL	MILLIM	ETERS	RS INCHES		
	MIN.	MAX.	MIN.	MAX.	NOTES
Α	3.56	4.83	.140	.190	
A1	1.14	1.40	.045	.055	
A2	2.03	2.92	.080	.115	
b	0.38	1.01	.015	.040	
ь1	0.38	0.97	.015	.038	5
b2	1,14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
С	0.36	0.61	.014	.024	
c1	0.36	0.56	.014	.022	5
D	14.22	16.51	.560	.650	4
D1	8.38	9.02	.330	.355	
D2	11.68	12.88	.460	.507	7
E	9.65	10.67	.380	.420	4,7
E1	6.86	8.89	.270	.350	7
E2	-	0.76	_	.030	8
e	2.54	BSC	.100	BSC	
e1	5.08	BSC	.200	BSC	
H1	5.84	6.86	.230	.270	7,8
L	12.70	14.73	.500	.580	
L1	3.56	4.06	.140	.160	3
øΡ	3.54	4.08	.139	.161	
Q	2.54	3.42	.100	.135	

#### LEAD ASSIGNMENTS

#### HEXFET

- 1.- GATE
- 2.- DRAIN 3.- SOURCE

## IGBTs, CoPACK

- 1 GATE
- 2.- COLLECTOR 3.- EMITTER

#### DIODES

1.- ANODE 2.- CATHODE 3.- ANODE

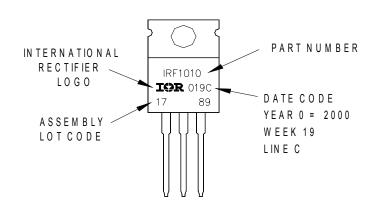
**TO-220AB Part Marking Information** 

EXAMPLE: THIS IS AN IRF1010

LOT CODE 1789

ASSEMBLED ON WW 19,2000 IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead - Free"

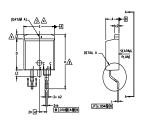


TO-220AB packages are not recommended for Surface Mount Application.

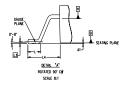
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

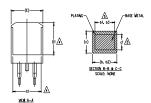


# D<sup>2</sup>Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))









- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S		Ŋ			
M B O L	MILLIM	ETERS	INC	HES	OTES
L	MIN.	MAX.	MIN.	MAX.	S
Α	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
b	0.51	0.99	.020	.039	
ь1	0.51	0.89	.020	.035	5
b2	1,14	1.78	.045	.070	
ь3	1,14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	-	.270		4
Ε	9.65	10.67	.380	.420	3,4
E1	6.22		.245		4
е	2.54	BSC	.100	BSC	
н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
L1	-	1.65	-	.066	4
L2	1.27	1.78	-	.070	
L3	0.25	BSC	.010	BSC	
L4	4.78	5.28	.188	.208	

#### LEAD ASSIGNMENTS

#### **HEXFET**

1.- GATE 2, 4.- DRAIN 3.- SOURCE

#### IGBTs, CoPACK

1.- GATE 2, 4.- COLLECTOR 3.- EMITTER

## DIODES

1.- ANODE \* 2, 4.- CATHODE 3 - ANODE

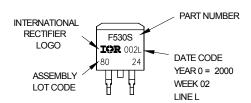
\* PART DEPENDENT.

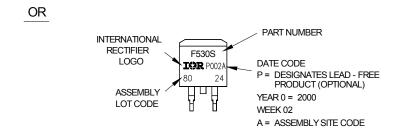
# D<sup>2</sup>Pak (TO-263AB) Part Marking Information

EXAMPLE: THIS IS AN IRF530S WITH LOT CODE 8024

ASSEMBLED ON WW 02, 2000 IN THE ASSEMBLY LINE "L"

Note: "P" in assembly line position indicates "Lead - Free"

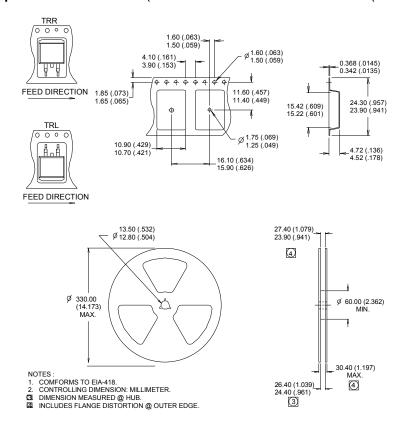




Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



# D<sup>2</sup>Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))



Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>



## Qualification Information<sup>†</sup>

Qualification Level	Industrial (per JEDEC JESD47F) ††				
Moisture Sensitivity Level	TO-220	N/A			
	D <sup>2</sup> Pak	MSL1			
RoHS Compliant	Yes				

Qualification standards can be found at International Rectifier's web site: http://www.irf.com/product-info/reliability/ †



IR WORLD HEADQUARTERS: 101 N. Sepulveda Blvd., El Segundo, California 90245, USA To contact International Rectifier, please visit <a href="http://www.irf.com/whoto-call/">http://www.irf.com/whoto-call/</a>

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